

## **Brief Biography**

Kar-Ann Toh is a full professor in the School of Electrical and Electronic Engineering at Yonsei University, South Korea. He received the PhD degree from Nanyang Technological University (NTU) Singapore. He worked for two years in the aerospace industry prior to his post-doctoral appointments at research centres in NTU from 1998 to 2002. He was affiliated with Institute for Infocomm Research in Singapore from 2002 to 2005 prior to his current appointment in Korea. His research interests include pattern classification, machine learning, optimization, neural networks and biometrics. He is a co-inventor of two US patents and has made several PCT filings related to biometric applications. Besides being an active member in publications, Dr. Toh has served as a program co-chair/member of technical program committee for international conferences related to biometrics and artificial intelligence. He is currently an associate editor of Journal of the Franklin Institute, IEEE Transactions on Biometrics, Behavior and Identity Science, Pattern Recognition Letters and IET Biometrics.